

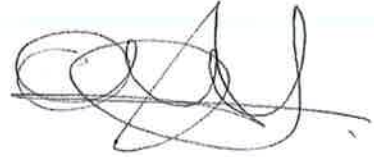


# Test Report Summary

## No E-15-I-053-PJ summary

### PRIME Certification Tests Cases for Service Nodes

<b>EQUIPMENT UNDER TEST</b>	PRIME Chip
<b>MODEL</b>	SM9400 EVK
<b>FIRMWARE VERSION</b>	v01.00.00
<b>CERTIFICATION SCOPE<sup>1</sup></b>	PHY and MAC
<b>MANUFACTURER</b>	Semitech Semiconductors Pty Ltd
<b>APPLICANT</b>	Mr. Sverrir Olafsson
<b>DATE OF RECEPTION</b>	March 31 <sup>th</sup> , 2015
<b>PRIME SPECIFICATION VERSION</b>	PRIME-Specification V1.3E
<b>TEST CASE VERSION</b>	PRIME Certification SN Tests Cases 1.2
<b>DATE OF EXECUTION</b>	From 6 till 14 April 2015
<b>DATE OF ISSUE OF REPORT</b>	Madrid, October 16 <sup>th</sup> , 2015

Responsible for tests	Head of Laboratory	PRIME Alliance Vice President
		
Pablo Jiménez	Juan Ignacio Sánchez	Oscar Marquez

\* This test report summary is granted on account of tests made at location of C. Almansa 105, Planta 2ª, Oficina 1, C.P. 28040 in Madrid, Spain.

\* The results of the present report apply only to the samples tested and the moment and conditions under which the measurements were performed.

\* The complete results, including remarks and limitations, are laid down in our complete test report no. E-15-I-052-PJ which can be obtained at DNV GL Smart Grid Lab. The certificate and the test report are indivisible.

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<sup>1</sup> IMPORTANT: Remarks apply to the implementation of this function. See complete test report (ANNEX I) for full details